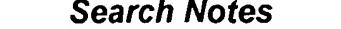


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/812,317	IKEHARA ET AL.
	Examiner Hung T. Vy	Art Unit 2821

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner